Notice of References Cited Application/Control No. 10/674,017 Examiner Brian K. Talbot Applicant(s)/Patent Under Reexamination BAEK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0180296	09-2004	Chen et al.	430/315
*	В	US-6,093,520	07-2000	Vladimirsky et al.	430/326
*	С	US-4,704,002	11-1987	Kikuchi et al.	349/43
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
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	K	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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